	Search Notes	
١		
l		
l		
١	, <u>                                     </u>	

Application/Control No.	o. Applicant(s)/Patent under Reexamination	
10/059,638	FRELECHOUX ET AL.	
Examiner	Art Unit	
Dung Dinh	2153	

SEARCHED				
Class	Subclass	Date	Examiner	
		<i>:</i>		
		,		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, JPO, EPO, IBMTDB, IEEE	11/9/2005	DD